

Description

The DFH10AL12EZC1 is a 3-level Power Module. It integrates 1200V SiC MOSFET chips and 1200V IGBT chips designed for the applications such as Solar Inverter, High frequency switching, Energy storage Systems etc.



Features

- Blocking voltage:1200V
- $R_{ds(on)}$: 9.5m Ω ($V_{GS}=15V$)/8.3m Ω ($V_{GS}=18V$)
- Low Switching Losses
- High current density
- Press FIT Contact Technology
- 175°C maximum junction temperature
- Thermistor inside

Applications

- Solar inverter Systems
- Three-level applications
- Energy Storage Systems
- High Frequency Switching application

Circuit diagram

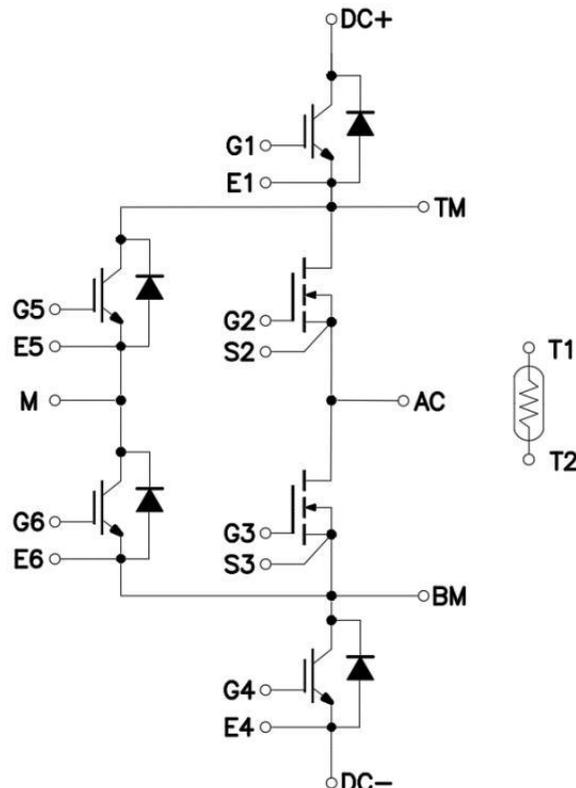


Figure 1. Out drawing & circuit diagram for DFH10AL12EZC1

Pin Configuration

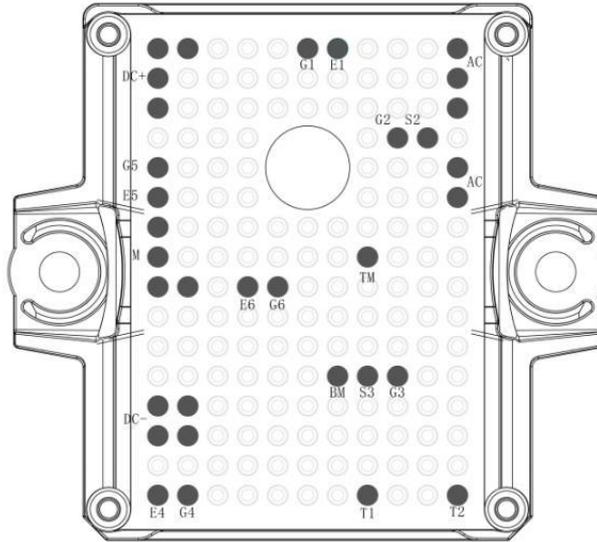


Figure 2. Pin configuration

Module

Parameter	Conditions	Value	Unit
Isolation voltage	Main terminal to base plate, RMS, f=50Hz, t=1 min	3.0	kV
Creepage distance	terminal to heatsink	11.5	mm
	terminal to terminal	6.3	
Clearance	terminal to heatsink	10.0	mm
	terminal to terminal	5.0	
Comparative tracking index	-	> 400	
Mounting torque for module mounting	Screw M4 baseplate to heatsink	1.8 to 2.2	Nm
Storage temperature	-	-40 to 125	°C
Weight	-	40	g

NTC characteristics

Symbol	Parameter	Condition	Value			Unit
			Min.	Typ.	Max.	
R ₂₅	Resistance	T _c =25°C	-	5	-	kΩ
ΔR/R	Deviation of R ₁₀₀	T _c =100°C, R ₁₀₀ =493Ω	-5	-	5	%
P ₂₅	Power dissipation	T _c =25°C	-	-	20	mW
B _{25/50}	B-value	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$	-	3375	-	K
B _{25/80}	B-value	$R_2 = R_{25} \exp [B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$	-	3411	-	K
B _{25/100}	B-value	$R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$	-	3433	-	K

Maximum Ratings (SiC MOSFET , $T_j=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Ratings	Unit
V_{DSS}	Drain-Source Voltage	G-S Short	1200	V
V_{GSS}	G-S Voltage	D-S Short, Note1	-10 to 22	V
I_{DS}	DC Continuous Drain Current	$T_C=125^\circ\text{C}$	100	A
I_{SD}	Source (Body diode) Current	$T_C=125^\circ\text{C}$	32	A
I_{DP}	Drain Pulse Current, Peak	Less than 1ms, Note2	200	A
T_j	junction temperature	-	-40 to 175	$^\circ\text{C}$

Note1: Recommended Operating Value, +18V/-5V, +15V/-4V, +15V/-5V

Note2: Pulse width limited by maximum junction temperature

Maximum Ratings (IGBT and FRD , $T_j=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Ratings	Unit
V_{CES}	Collector-Emitter Voltage	G-E Short	1200	V
V_{GES}	Gate-Emitter Voltage	C-E Short	± 20	V
I_{CN}	DC Continuous Collector Current	$T_C=135^\circ\text{C}$	100	A
I_{CM}	Pulse Collector Current	$t_p=1\text{ms}$, Note1	200	A
I_F	Diode forward Current	$T_C=100^\circ\text{C}$	100	A
I_{FRM}	Repetitive peak forward Current	$t_p=1\text{ms}$, Note1	200	A
T_j	junction temperature	-	-40 to 175	$^\circ\text{C}$
T_{stg}	Storage temperature	-	-40 to 125	$^\circ\text{C}$

Note1: Pulse width limited by maximum junction temperature

MOSFET Electrical characteristics ($T_j=25^\circ\text{C}$ unless otherwise specified, chip)

Symbol	Item	Condition	Value			Unit
			Min.	Typ.	Max	

$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=200\mu A$		1200	-	-	V
I_{DSS}	Zero gate voltage drain Current	$V_{DS}=1200V, V_{GS}=0V$		-	2	-	μA
$V_{GS(th)}$	Gate-source threshold Voltage	$I_D=70mA, V_{DS}=V_{GS}, T_j=25^\circ C$		1.8	2.7	-	V
		$I_D=70mA, V_{DS}=V_{GS}, T_j=175^\circ C$		-	2.05	-	V
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=20V, V_{DS}=0V, T_j=25^\circ C$		-	200	-	nA
$R_{DS(on)}$ (Chip)	Static drain-source On-state resistance	$I_D=100A$ $V_{GS}=15V$	$T_j=25^\circ C$	-	9.5	-	m Ω
			$T_j=175^\circ C$	-	14.3	-	m Ω
		$I_D=100A$ $V_{GS}=+18V$	$T_j=25^\circ C$	-	8.3	12.5	m Ω
			$T_j=175^\circ C$	-	12.6	-	m Ω
$V_{DS(on)}$ (Chip)	Static drain-source On-state Voltage	$I_D=100A$ $V_{GS}=15V$	$T_j=25^\circ C$	-	0.95	-	V
			$T_j=175^\circ C$	-	1.43	-	V
		$I_D=100A$ $V_{GS}=+18V$	$T_j=25^\circ C$	-	0.83	1.25	V
			$T_j=175^\circ C$	-	1.26	-	V
C_{iss}	Input Capacitance	$V_D=800V, V_{GS}=0V$ $f=1MHz, V_{AC}=25mV$		-	11.6	-	nF
C_{oss}	Output Capacitance			-	0.352	-	nF
C_{rss}	Reverse transfer Capacitance			-	0.028	-	nF

Q _G	Total gate charge	V _{DD} =800V, I _D =120A, V _{GS} =-5/+15V	-	360	-	nC	
R _{Gint}	Internal Gate Resistance	f=1Mhz, V _{AC} =25mV	-	0.65	-	Ω	
t _{d(on)}	Turn-on delay time	V _{DD} =600V I _D =100A V _{GS} =+15V/-4V R _g =5.1Ω Inductive load switching operation	T _j =25°C	-	43	-	ns
			T _j =150°C	-	40	-	
t _r	Rise time		T _j =25°C	-	23	-	ns
			T _j =150°C	-	19	-	
t _{d(off)}	Turn-off delay time		T _j =25°C	-	112	-	ns
			T _j =150°C	-	120	-	
t _f	Fall time		T _j =25°C	-	15	-	ns
			T _j =150°C	-	40	-	
E _{on}	Turn-on power dissipation		T _j =25°C	-	2.22	-	mJ
			T _j =150°C	-	2.31	-	
E _{off}	Turn-off power dissipation	T _j =25°C	-	1.50	-	mJ	
		T _j =150°C	-	1.59	-		
R _{th(j-c)}	FET Thermal Resistance	Junction to Case/MOSFET	-	0.32	-	K/W	
R _{th(c-s)}	Thermal Resistance, Case to sink (Conductive Grease applied) , Note1		-	0.12	-	K/W	

Note1: Assumes Thermal Conductivity of grease is 2.8W/m·K and thickness is 50um.

Body Diode Electrical characteristics (T_j=25°C unless otherwise specified, chip: Target)

Symbol	Item	Condition	Value			Unit	
			Min.	Typ.	Max		
V _{SD}	Body Diode Forward Voltage	V _{GS} = -5V I _{SD} = 100A	T _j =25°C	-	5.1	-	V
			T _j =175°C	-	4.6	-	
T _{rr}	Reverse recovery time	V _{DD} =600V I _D =100A V _{GS} =+15/-4V R _g =5.1Ω Inductive load switching operation	T _j =25°C	-	26	-	ns
			T _j =150°C	-	50	-	
Q _{rr}	Reverse recovery charge		T _j =25°C	-	0.75	-	μC
			T _j =150°C	-	3.20	-	
E _{rr}	Diode switching power	T _j =25°C	-	0.12	-	mJ	

dissipation		$T_j=150^{\circ}\text{C}$	-	0.79	-
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IGBT Electrical characteristics ($T_j=25^{\circ}\text{C}$ unless otherwise specified, chip)

Symbol	Item	Condition		Value			Unit
				Min.	Typ.	Max	
$V_{CE(sat)}$ (Chip)	Collector-Emitter Saturation Voltage	$I_C=100\text{A}$ $V_{GE}=15\text{V}$	$T_j=25^{\circ}\text{C}$	-	1.56	-	V
			$T_j=175^{\circ}\text{C}$	-	1.81	-	V
$V_{GE(th)}$	Gate-Emitter threshold Voltage	$I_C=2.6\text{mA}$, $V_{CE}=10\text{V}$		-	5.9	-	V
Q_G	Gate charge	$V_{GE}=-15\text{V}$ to $+15\text{V}$		-	2.0	-	μC
R_{Gint}	Internal gate resistor	-	$T_j=25^{\circ}\text{C}$	-	13	-	Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}$, $V_{GE}=0\text{V}$ $f=1\text{MHz}$	$T_j=25^{\circ}\text{C}$	-	3.56	-	nF
C_{res}	Reverse transfer Capacitance			-	0.04	-	nF
I_{CES}	Collector- Emitter Cut off Current	$V_{CE}=1200\text{V}$, $V_{GE}=0\text{V}$	$T_j=25^{\circ}\text{C}$	-	-	0.01	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=20\text{V}$, $V_{CE}=0\text{V}$	$T_j=25^{\circ}\text{C}$	-	-	0.1	μA

Preliminary datasheet _Ver.C EN

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t _{d(on)}	Turn-on delay time	V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load	T _j =25°C	-	100	-	ns			
			T _j =125°C	-	108	-				
			T _j =175°C	-	114	-				
t _r	Rise time		V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load	T _j =25°C	-	31	-	ns		
				T _j =125°C	-	34	-			
				T _j =175°C	-	37	-			
t _{d(off)}	Turn-off delay time			V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load	T _j =25°C	-	228	-	ns	
					T _j =125°C	-	299	-		
					T _j =175°C	-	342	-		
t _f	Fall time				V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load	T _j =25°C	-	210	-	ns
						T _j =125°C	-	308	-	
						T _j =175°C	-	384	-	
E _{on}	Turn-on power dissipation	V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load				T _j =25°C	-	1.24	-	mJ
						T _j =125°C	-	1.80	-	
						T _j =175°C	-	2.01	-	
E _{off}	Turn-off power dissipation		V _{CC} =600V I _C = 100A V _{GE} =+15V/-15V R _g =1.5Ω Inductive load			T _j =25°C	-	6.7	-	mJ
						T _j =125°C	-	12.2	-	
						T _j =175°C	-	15.1	-	
R _{th(j-c)}	Thermal Resistance, Junction to Case (IGBT)			-		0.16	-	K/W		
R _{th(c-s)}	Thermal Resistance, Case to sink (Conductive Grease applied) , Note1			-		0.12	-	K/W		

Note1: Assumes Thermal Conductivity of grease is 2.8W/m·K and thickness is 50um.

Freewheeling Diode Electrical characteristics (T_j =25°C unless otherwise specified, chip)

Symbol	Item	Condition	Value			Unit	
			Min.	Typ.	Max		
V _F	Diode Forward Voltage	I _F =100A, V _{GE} =0V	T _j =25°C	-	1.9	-	V
			T _j =175°C	-	1.75	-	
			T _j =25°C	-	0.36	-	

t _{rr}	Reverse recovery time	(Switch side) V _{CC} =600V	T _j =125°C	-	0.53	-	us
			T _j =175°C	-	0.71	-	
I _{RM}	Peak reverse recovery Current	I _C =100A V _{GE} = +15V/-15V R _g =1.5Ω	T _j =25°C	-	103	-	A
			T _j =125°C	-	131	-	
Q _{rr}	Recovered charge	(FRD side) V _{rr} =600V I _F =100A V _{GE} = +15V/-15V Inductive load switching operation	T _j =175°C	-	154	-	uC
			T _j =25°C	-	9.32	-	
E _{rr}	Reverse recovered energy		T _j =125°C	-	16.7	-	mJ
			T _j =175°C	-	27.2	-	
			T _j =25°C	-	3.74	-	
R _{th(j-c)}	Thermal Resistance, Junction to Case (Diode)		-	0.28	-	K/W	
R _{th(c-s)}	Thermal Resistance, Case to sink (Conductive Grease applied) , Note1		-	0.12	-	K/W	

Note1: Assumes Thermal Conductivity of grease is 2.8W/m·K and thickness is 50um.

Test Conditions

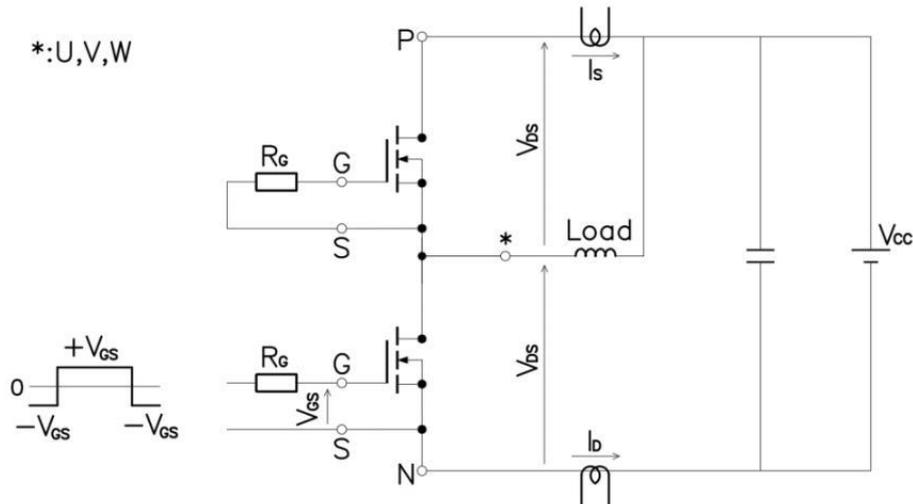


Figure 3. Switching time measure circuit

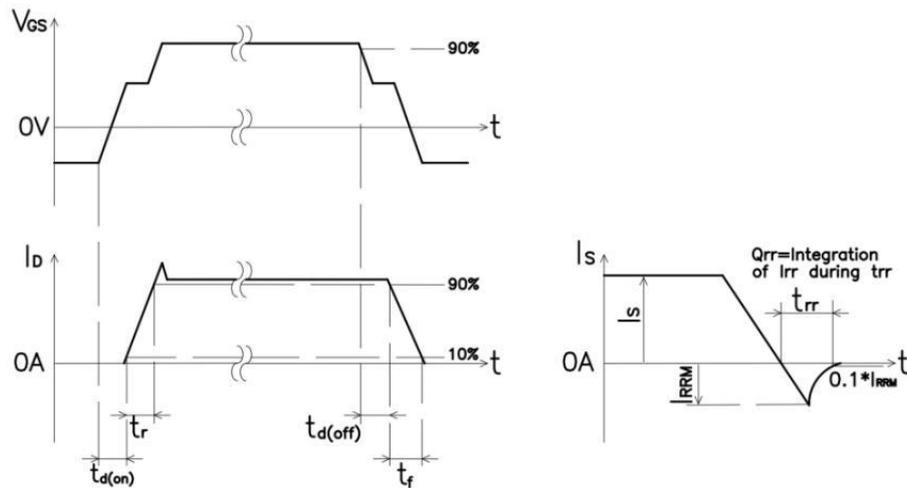


Figure 4. Switching time definition

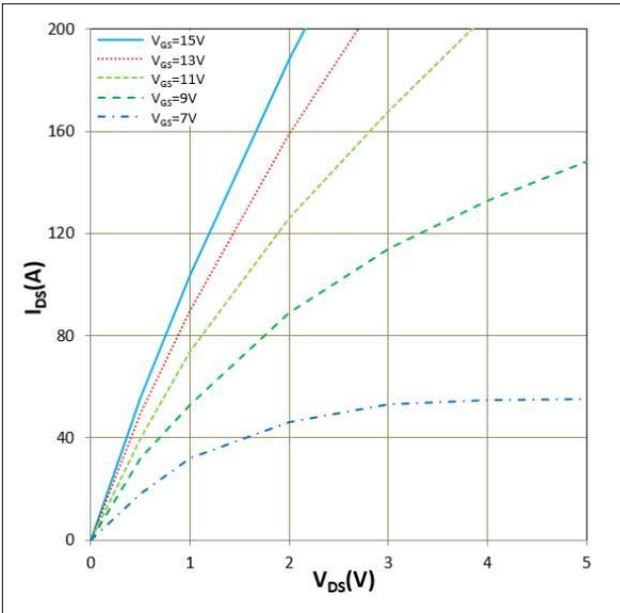


Figure 5. I_{DS} vs V_{DS} , SiC MOSFET
 $T_j = 25^\circ\text{C}$, V_{GS} parameter

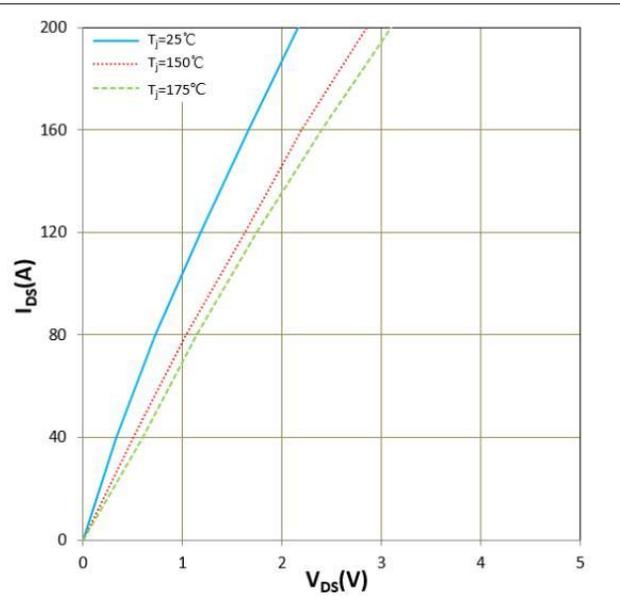


Figure 6. I_{DS} vs V_{DS} , SiC MOSFET
 $V_{GS} = +15\text{V}$

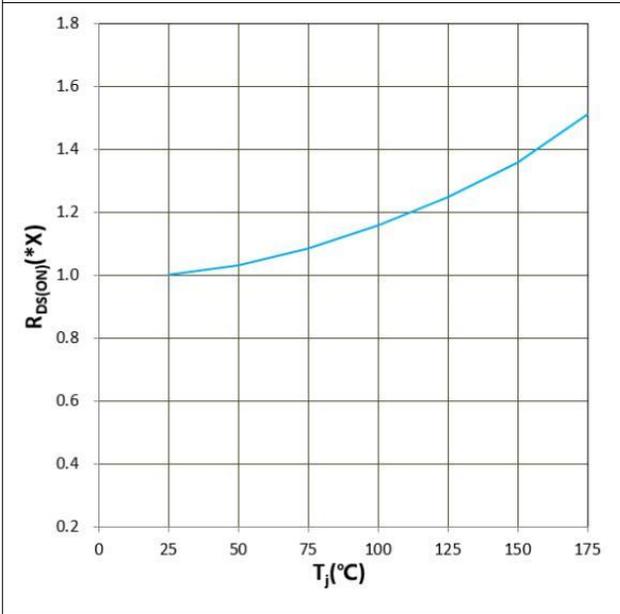


Figure 7. $R_{DS(ON)}$ vs T_j , SiC MOSFET
 $V_{GS} = +15\text{V}$, $I_D = 100\text{A}$, $1.0X = 9.5\text{m}\Omega$

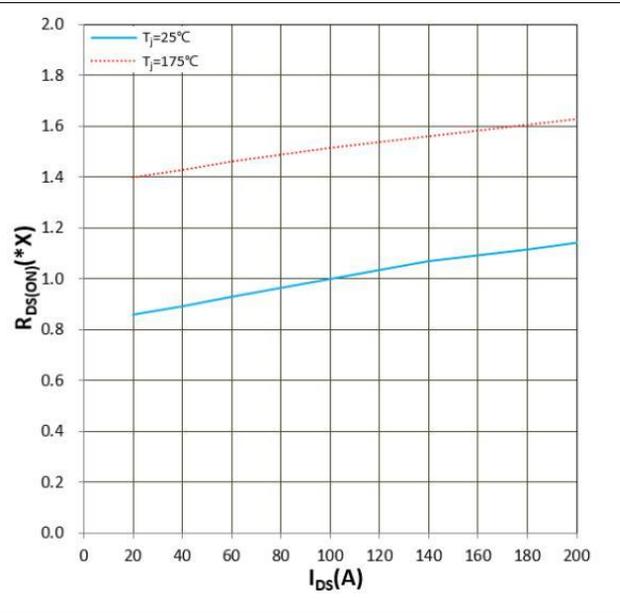


Figure 8. $R_{DS(ON)}$ vs I_{DS} , SiC MOSFET
 $V_{GS} = +15\text{V}$, $1.0X = 9.5\text{m}\Omega$

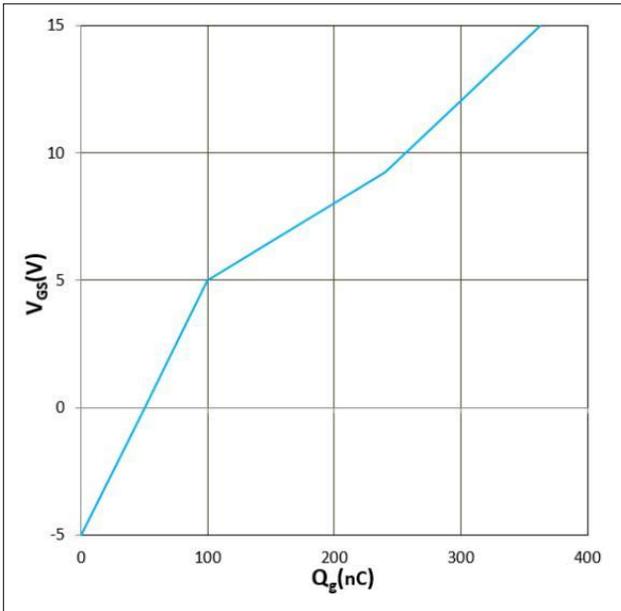


Figure 9. V_{GS} vs Q_g , SiC MOSFET
 $V_{DS} = 800V$, $I_D = 120A$, $T_j = 25^\circ C$

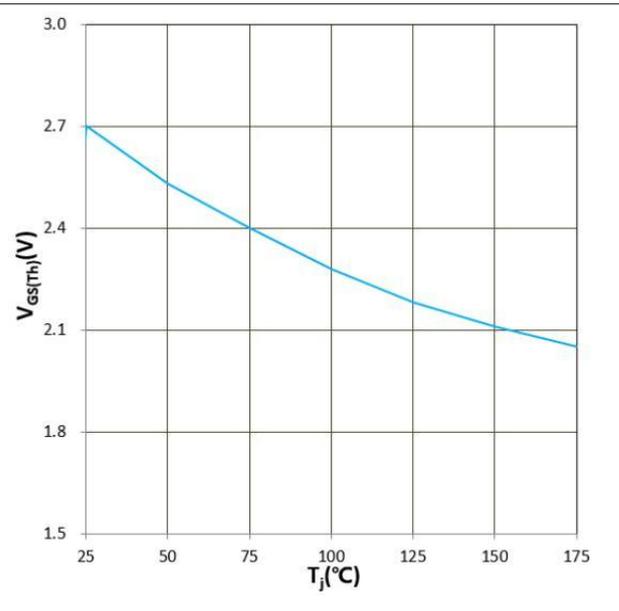


Figure 10. $V_{GS(TH)}$ vs T_j , SiC MOSFET
 $V_{GS} = V_{DS}$, $I_D = 70mA$

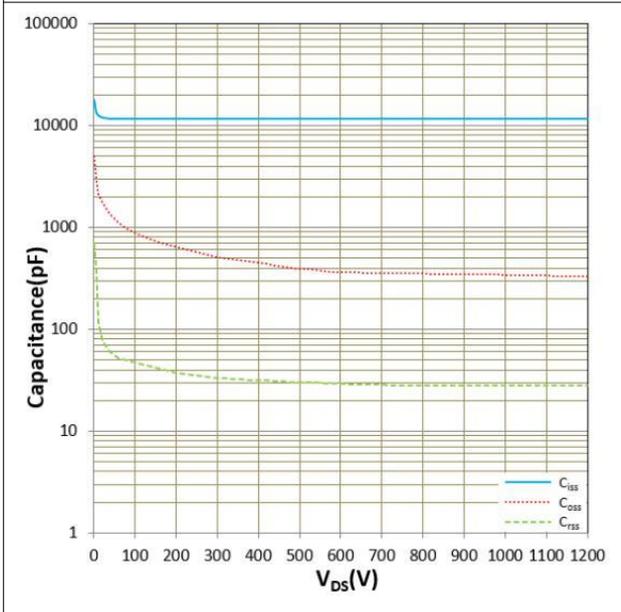


Figure 11. C_{iss} , C_{oss} , C_{rss} vs V_{DS} , SiC MOSFET
 $T_j = 25^\circ C$, $V_{GS} = 0V$, $f = 1MHz$

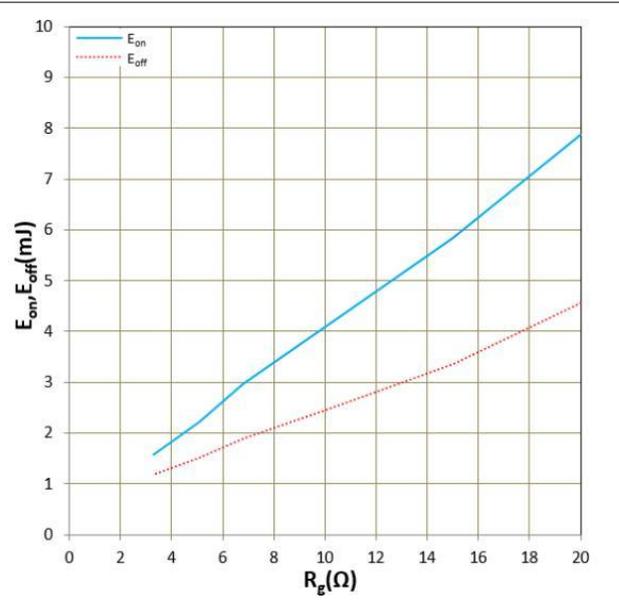


Figure 12. E_{on} , E_{off} vs R_g , SiC MOSFET
 $T_j = 25^\circ C$, $V_{CC} = 600V$, $I_D = 100A$, $V_{GS} = +15V/-4V$

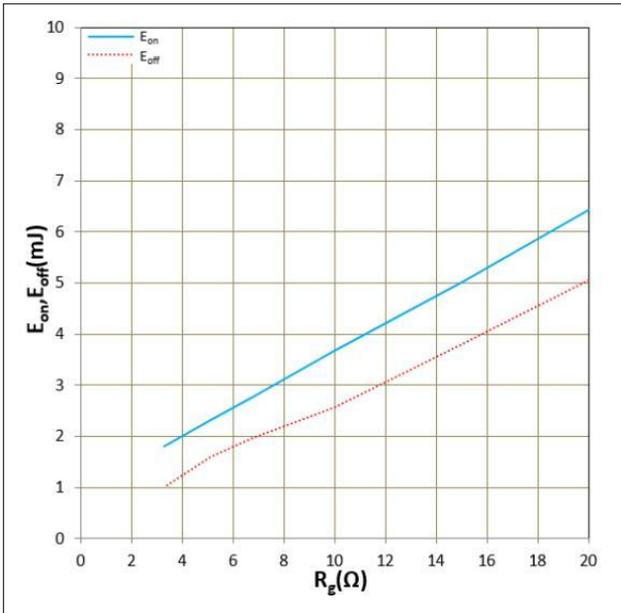


Figure 13. E_{on} , E_{off} vs R_g , SiC MOSFET
 $T_j = 150^\circ\text{C}$, $V_{CC} = 600\text{V}$, $I_D = 100\text{A}$, $V_{GS} = +15\text{V}/-4\text{V}$

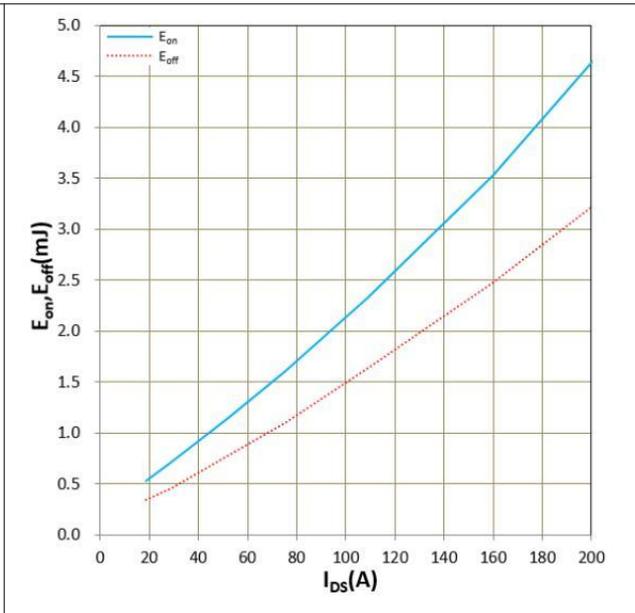


Figure 14. E_{on} , E_{off} vs I_{DS} , SiC MOSFET
 $T_j = 25^\circ\text{C}$, $V_{CC} = 600\text{V}$, $R_g = 5.1\Omega$, $V_{GS} = +15\text{V}/-4\text{V}$

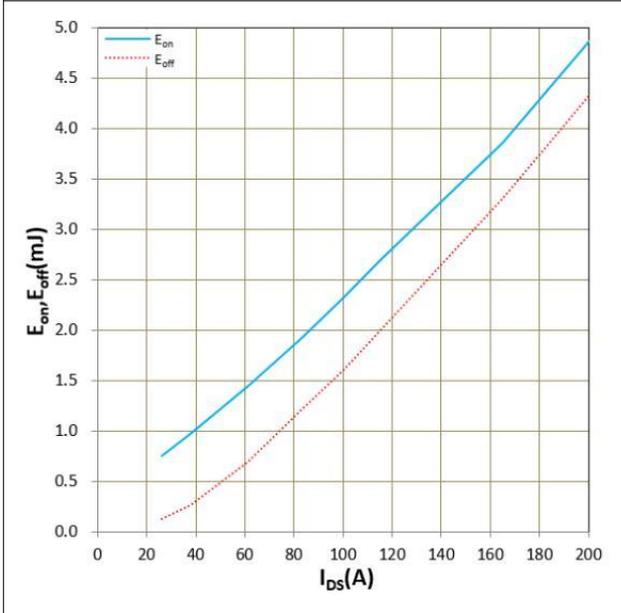


Figure 15. E_{on} , E_{off} vs I_{DS} , SiC MOSFET
 $T_j = 150^\circ\text{C}$, $V_{CC} = 600\text{V}$, $R_g = 5.1\Omega$, $V_{GS} = +15\text{V}/-4\text{V}$

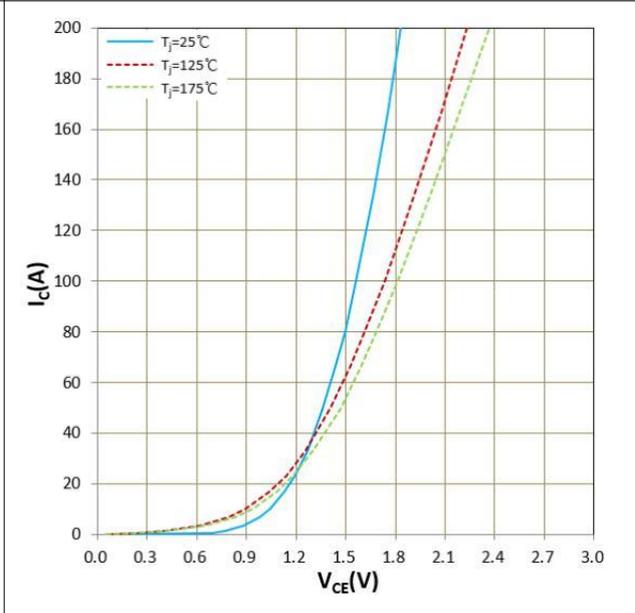


Figure 16. I_c vs V_{GE} , IGBT
 $V_{GE} = 15\text{V}$

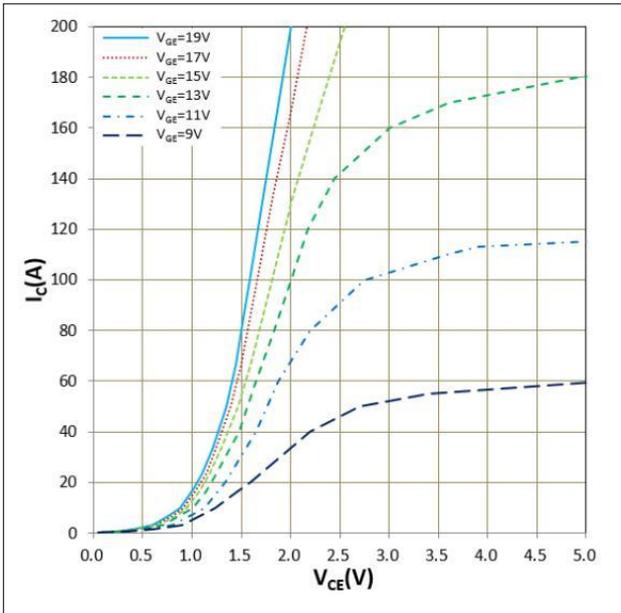


Figure 17. I_c vs V_{CE} , IGBT
 $T_j=175^\circ\text{C}$

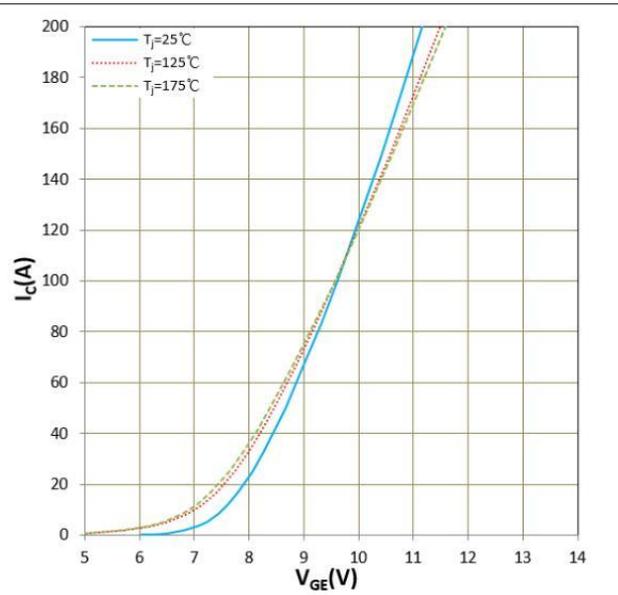


Figure 18. I_c vs V_{GE} , IGBT
 $V_{CE}=20\text{V}$

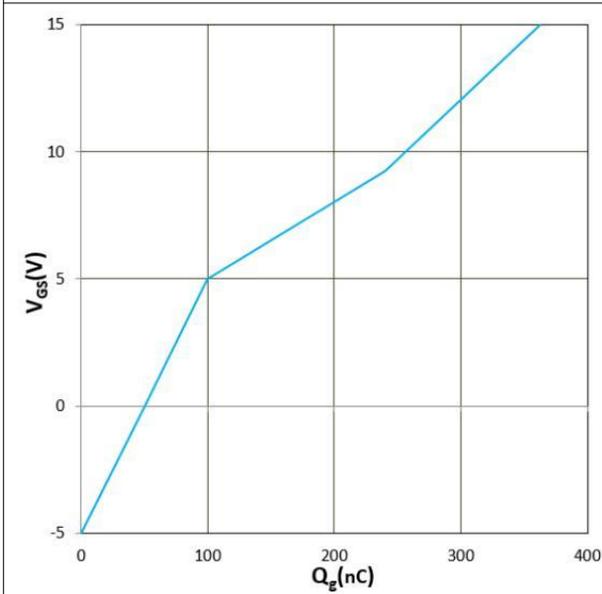


Figure 19. V_{GE} vs Q_g , IGBT
 $V_{CC}=600\text{V}$, $I_D=100\text{A}$, $T_j=25^\circ\text{C}$

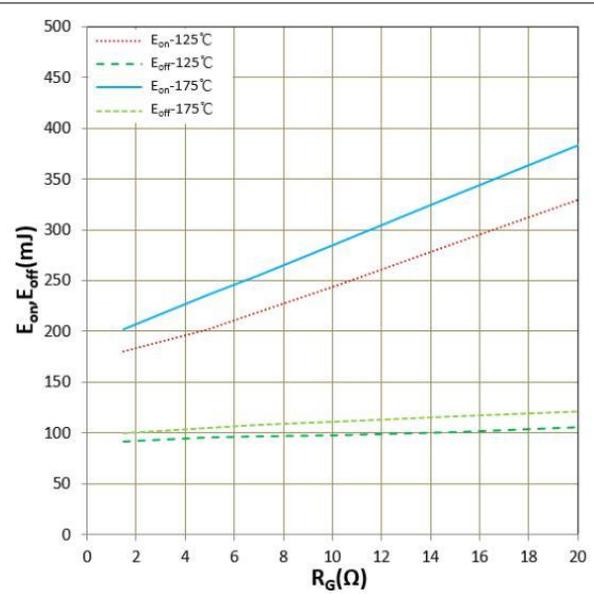


Figure 20. E_{on} , E_{off} vs I_c , IGBT
 $V_{CC}=600\text{V}$, $V_{GE}=\pm 15\text{V}$, $R_g=1.5\Omega$

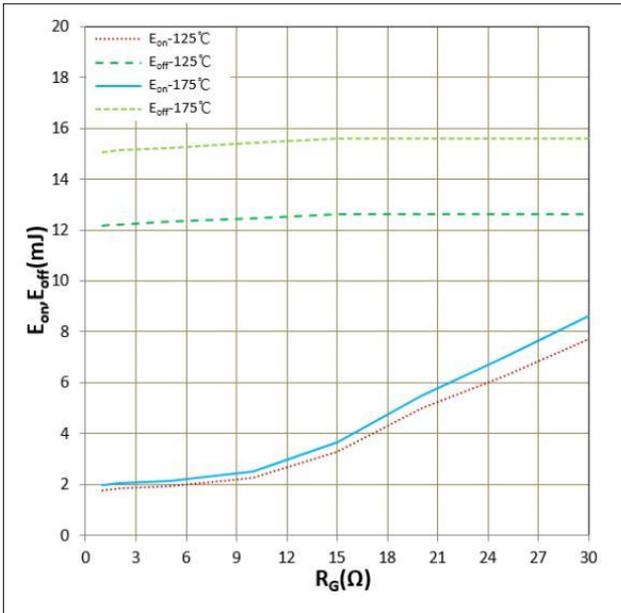


Figure 21. E_{on} , E_{off} vs R_g , IGBT
 $V_{CC}=600V$, $V_{GE}=\pm 15V$, $I_C=100A$

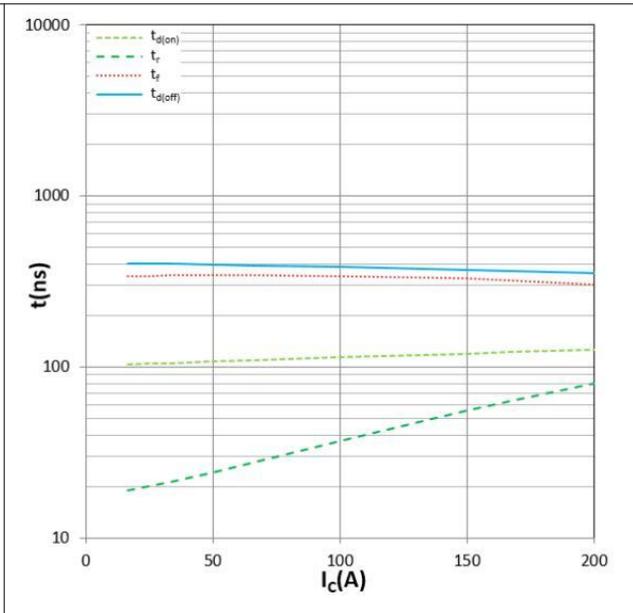


Figure 22. Switching time vs I_c , IGBT
 $V_{CC}=600V$, $V_{GE}=\pm 15V$, $R_g = 1.5\Omega$, $T_j=175^\circ C$

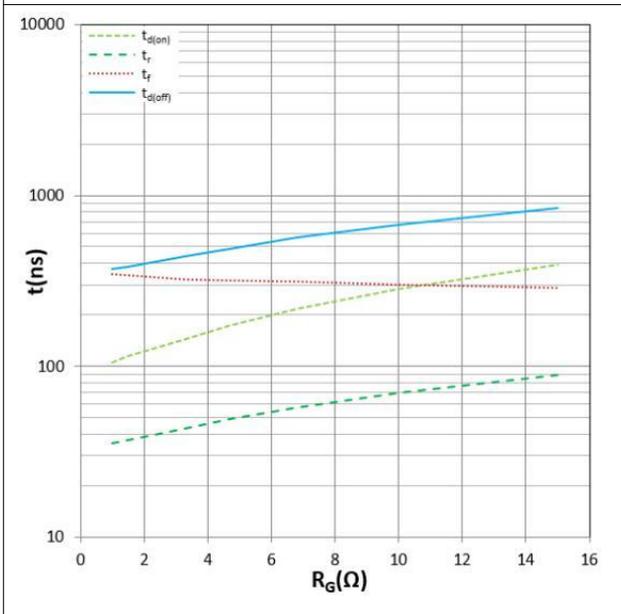


Figure 23. Switching time vs R_g , IGBT
 $V_{CC}=600V$, $V_{GE}=\pm 15V$, $I_C = 100A$, $T_j=175^\circ C$

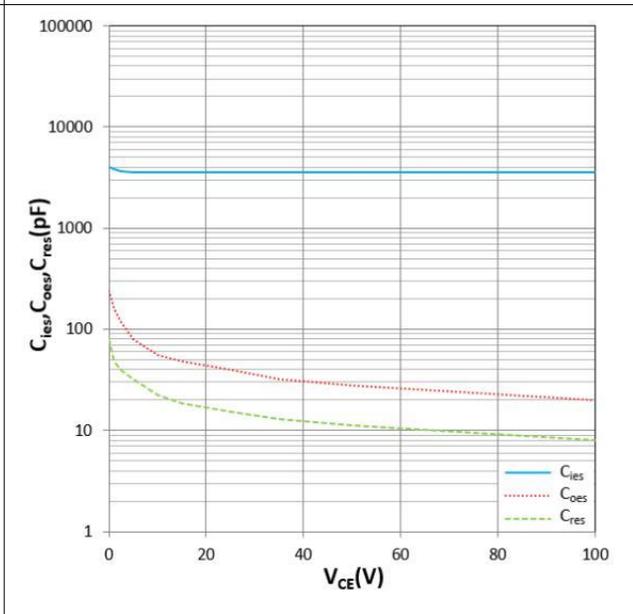


Figure 24. C_{ies} , C_{oss} , C_{res} vs V_{CE} , IGBT
 $T_j=25^\circ C$, $V_{GE}=0V$, $f=1MHz$

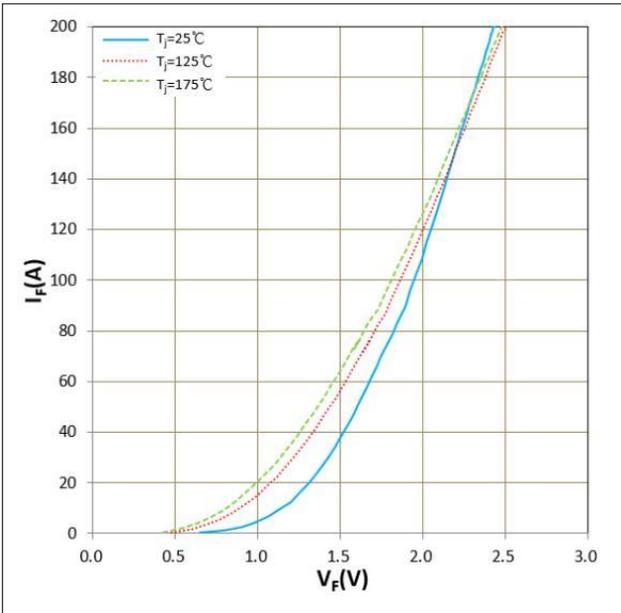


Figure 25. I_F vs V_F , Freewheeling Diode

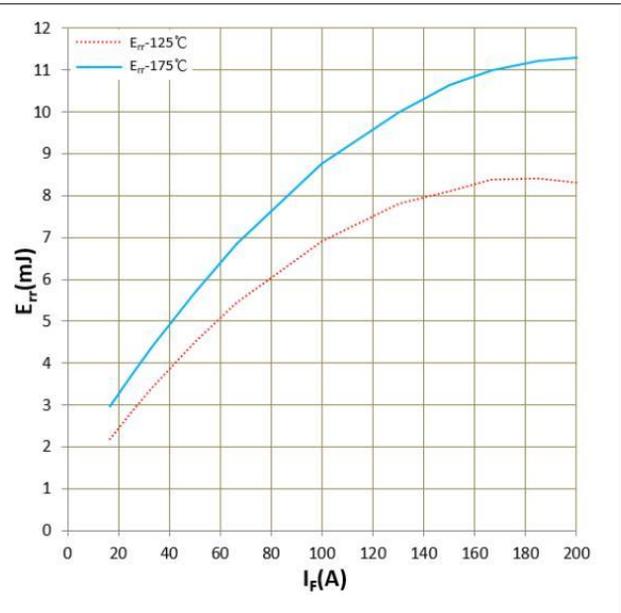


Figure 26. E_{rr} vs I_F , Freewheeling Diode
 $V_{CC}=600V$, $R_g=1.5\Omega$

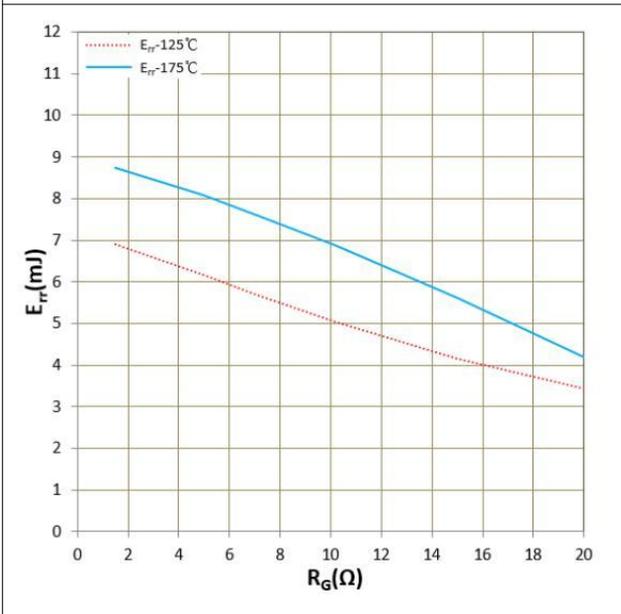


Figure 27. E_{rr} vs R_g , Freewheeling Diode
 $V_{CC}=600V$, $I_C=100A$



DFH10AL12EZC1

1200V 3-Level Hybrid Power Module

Please contact the sales staff (Sales@leapers-power.com) for further information on the product, technology, delivery terms, conditions and prices.

Preliminary datasheet _Ver.C EN

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